Part 2: Process

Fundamental Technology

Real men own fabs.

W.J. Saunders III, Chairman and CEO of Advanced Micro Devices Inc.

Building a new fab is like playing Russian roulette. When you build a fab, you hold the gun to your head, pull the trigger and wait three years to see if you're dead.

Unnamed IC company executive. (Integrated Circuit Design, September 1996)

Outline

- CMOS Processing
  - Wafer Production
  - CMOS Process Outline
  - Photolithography
  - Material Deposition & Removal
  - Oxide Growth & Removal
- Layout Design
  - Layer map
  - Layout examples
  - Stick diagrams
- Design Rules
  - Only very briefly

Course Material for 02-Process

Chapter 2, 2nd ed.

P = primair, I = Illustratie, O = overslaan

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P	2.2.3	Some Recurring Process Steps	41-42
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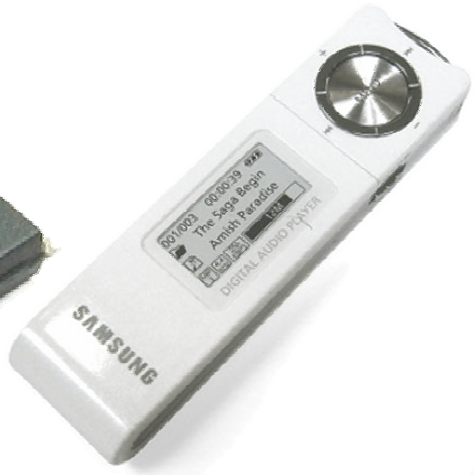
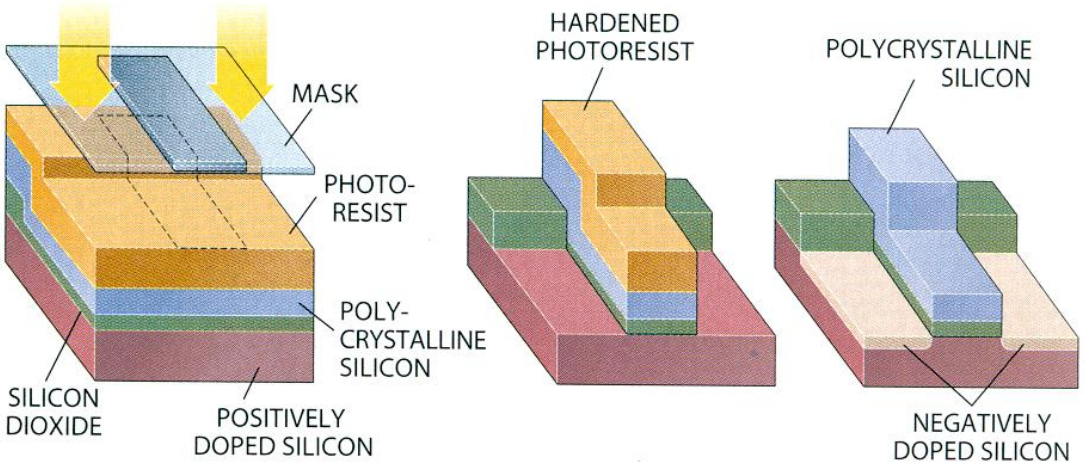
CMOS Processing

- Overview
- Photolithography
- Material Deposition & Removal
- Oxide Growth & Removal

IC Technology

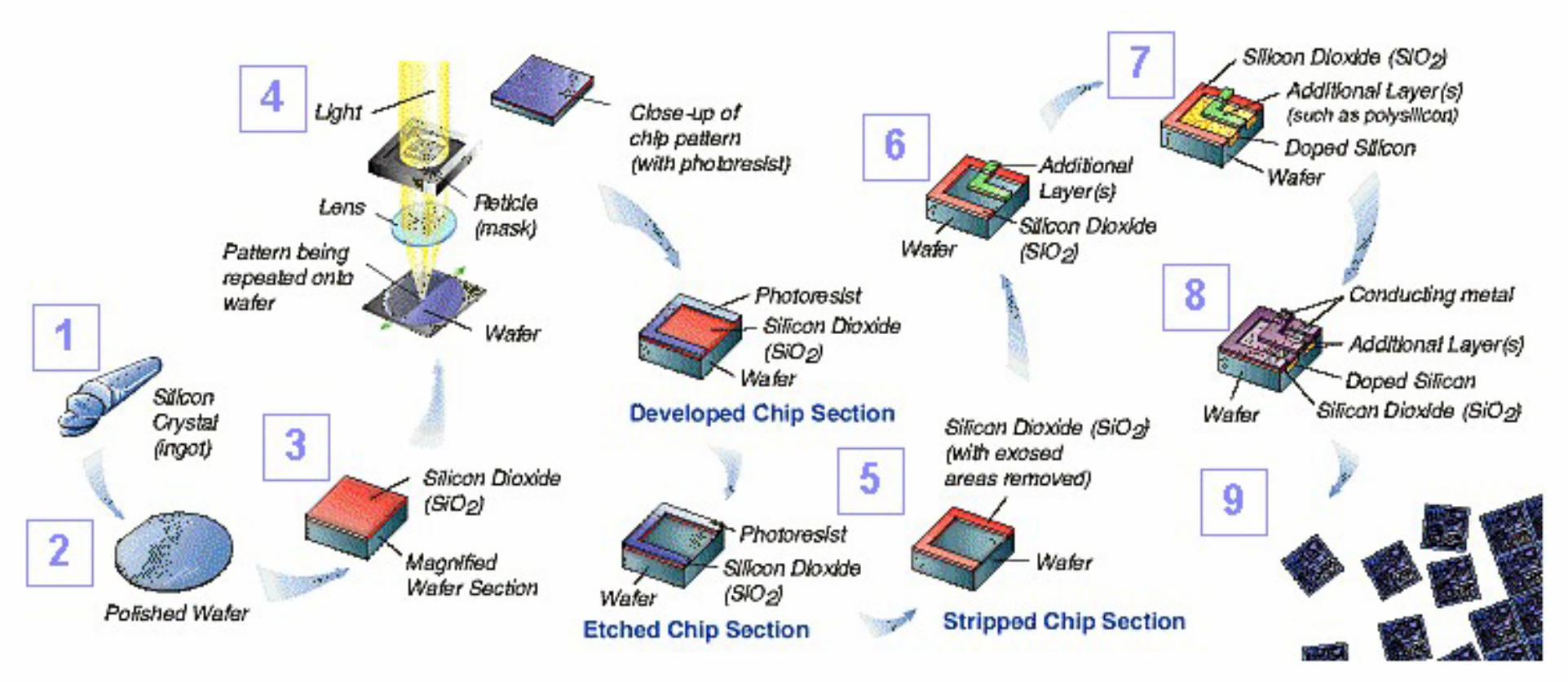


- cleaning
- deposition
- apply photoresist
- exposure
- development
- etching
- remove resist



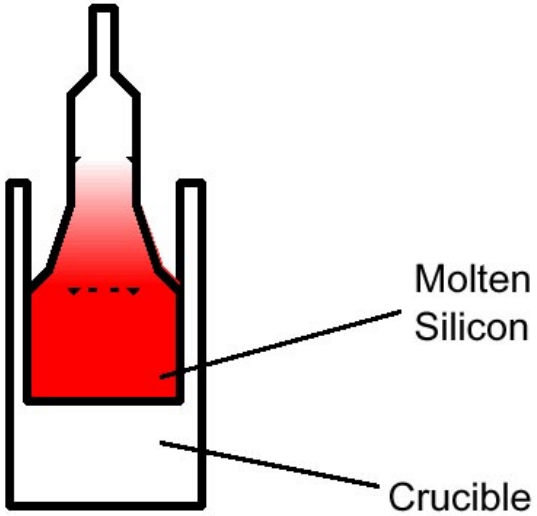
Multiple cycles, 100's STEPS in total

Another Overview of Semiconductor Processing

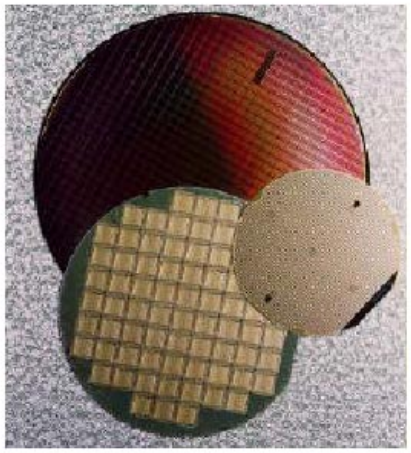


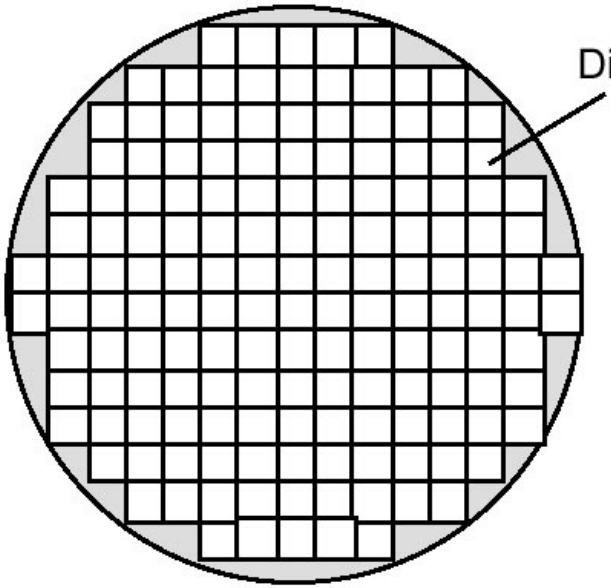
Wafer Processing – Czochralski Method

- **Start with crucible of molten silicon (≈1425ºC)**
- **Insert crystal seed in melt**
- **Slowly rotate/raise seed to form single crystal boule**
- **After cooling, slice boule into wafers & polish**



Wafer Structure

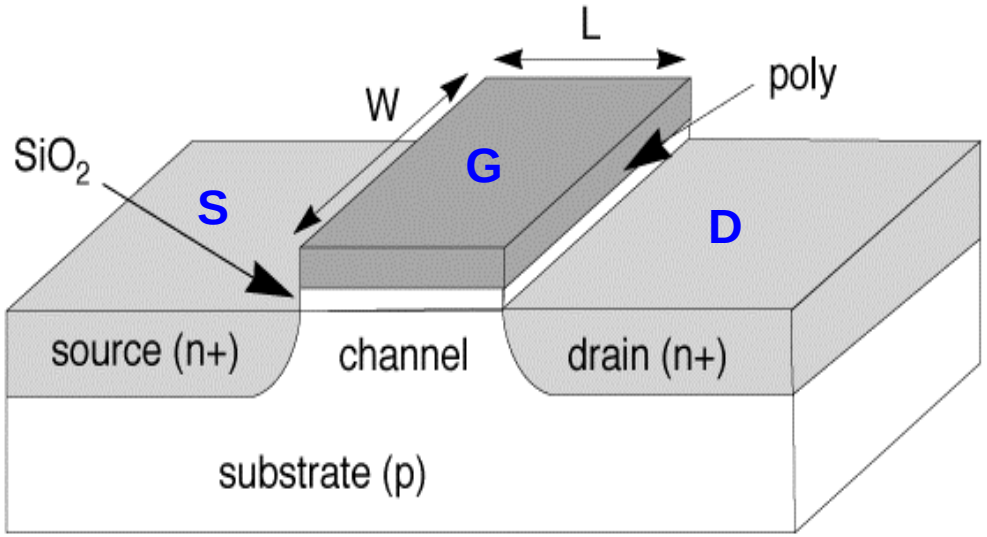


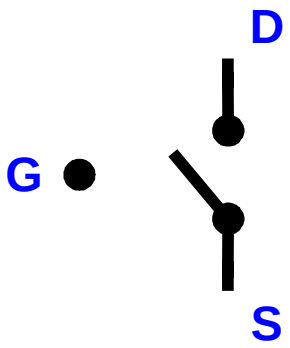


300 mm wafer (sematech)

CMOS Process Outline

MOS Transistor



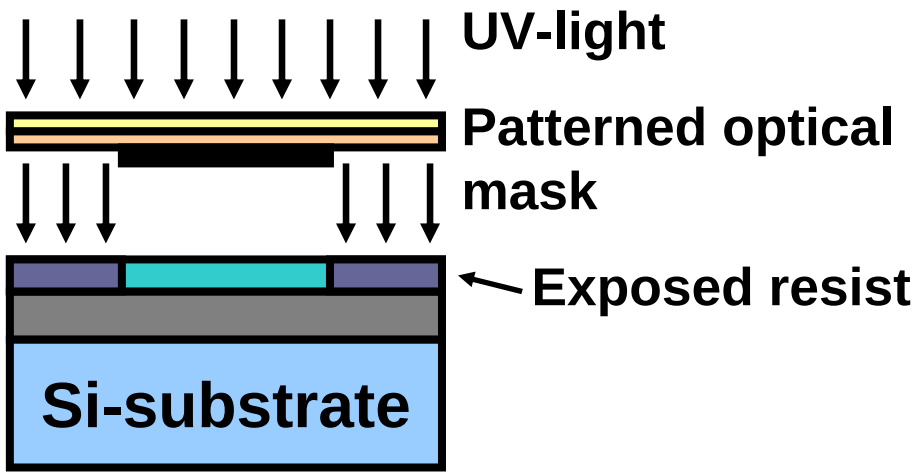


Position of switch depends on gate to source voltage

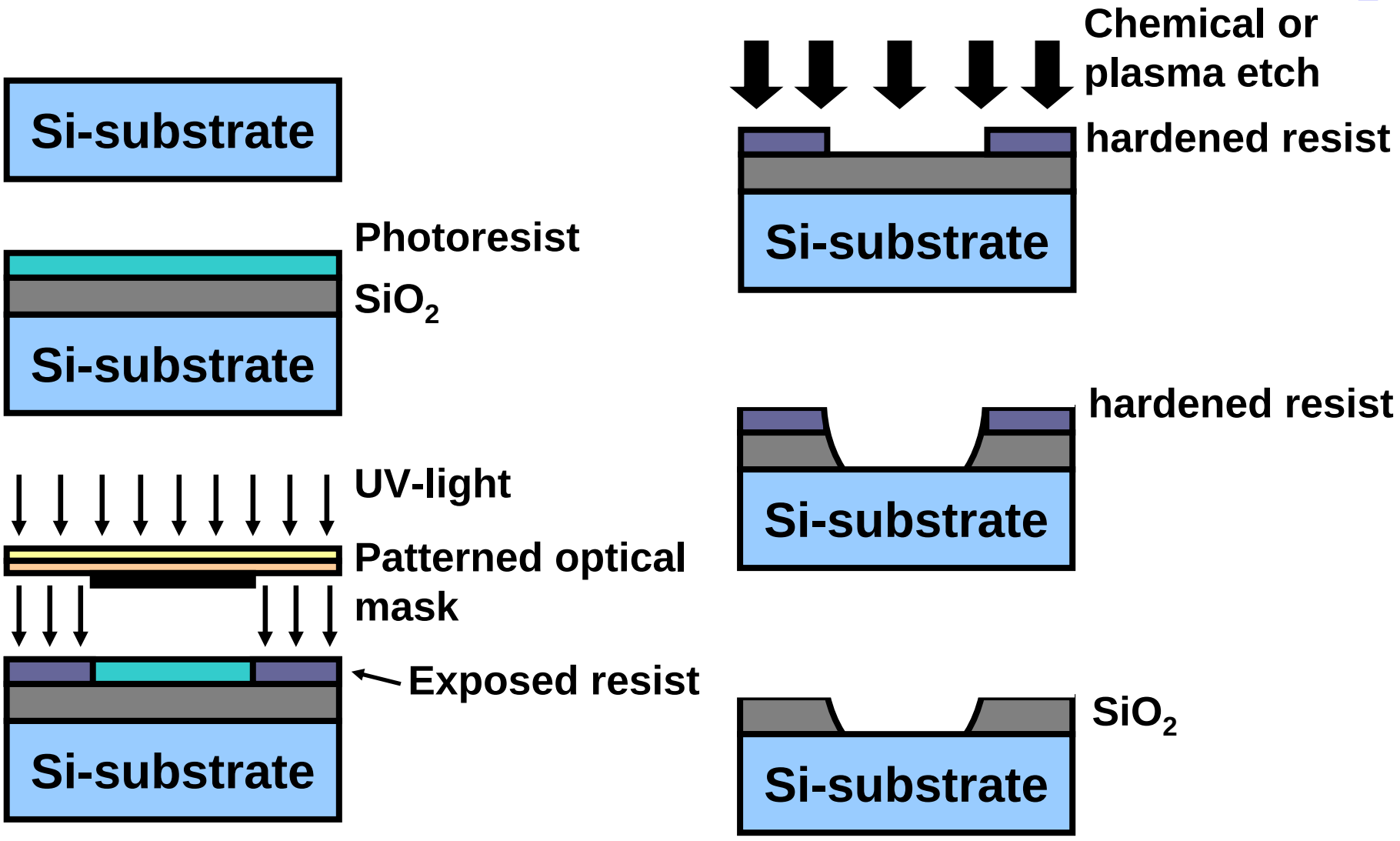
V_{GS}	NMOS	PMOS
hi	closed	open
lo	open	closed

How Patterns on a Chip are Created

- **Basic Principle: Photolithography**
  - **Like projecting an image through a photographic negative (or positive)**
- **Coat wafer with Photoresist**
- **Shine UV light through glass mask**
- **Develop: dunk in acid to remove exposed areas ("pos.") or unexposed areas ("neg.")**



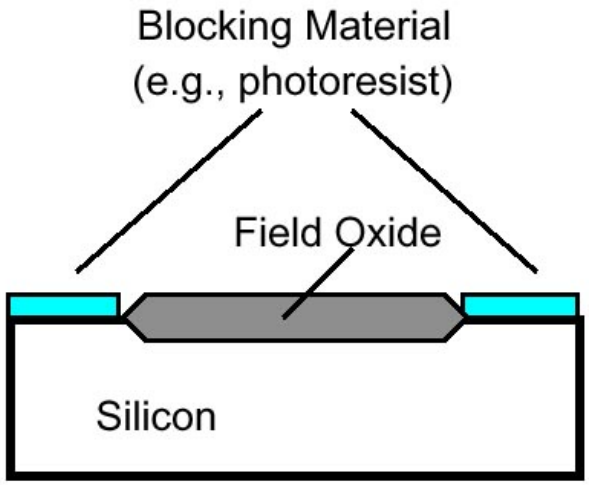
Example: Etching Step, opening of SIO_2



Etching is for removal of material, similar masking principles for deposition (adding of material)

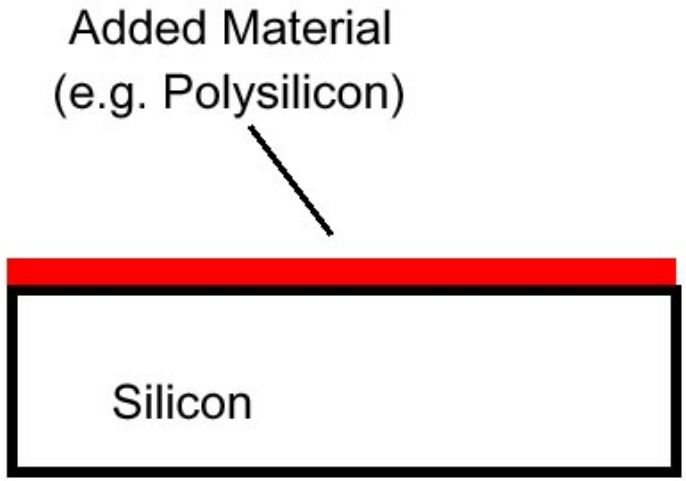
Oxidation

- **SiO_2 formed by oxidation**
  - **Wet oxidation: heat with water (900ºC - 1200 ºC)**
  - **Dry oxidation:heat with pure oxygen (1200 ºC)**
- **Oxide occupies more volume**
- **Alternative: deposition**



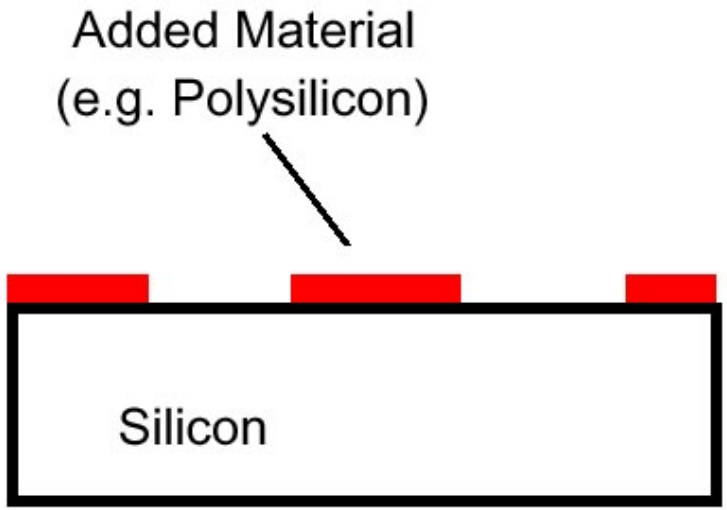
Adding Materials

- **Add materials on top of silicon**
  - **Polysilicon**
  - **Metal**
  - **SiO_2**
- **Methods**
  - **Vapor deposition**
  - **Sputtering (Metal ions)**



Patterning Added Materials

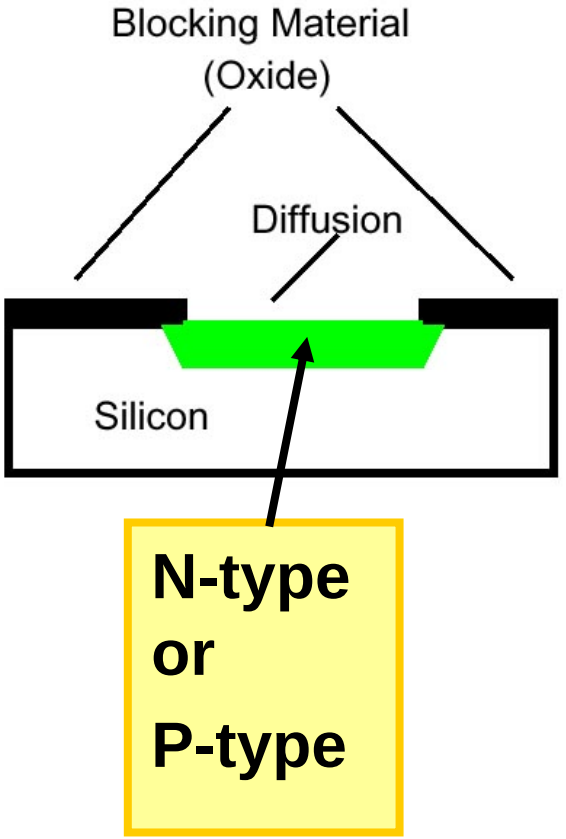
- **Add material to wafer**
- **Coat with photoresist**
- **Selectively remove photo resist (PR), after exposure through mask**
- **Remove unprotected (by PR) material**
- **Remove remaining PR**



Diffusion

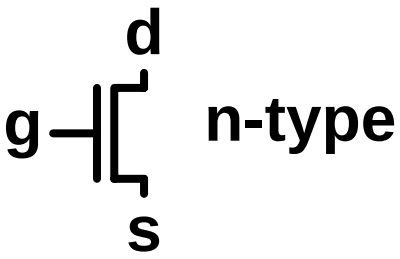
- Modify electrical properties of Si:
  - N-type (extra electrons)
  - or p-type

    (fewer electrons ⇔ extra holes)
- Introduce dopant via epitaxy or ion implant e.g. Arsenic (N), Boron (P)
- Allow dopants to diffuse
- Block diffusion in selective areas using oxide or PR (photo-resist)
- Diffusion spreads both vertically, horizontally

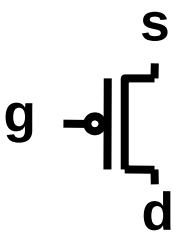


CMOS – *Complementary* Metal Oxide Semiconductor Technology

2 Distinct Transistor Types



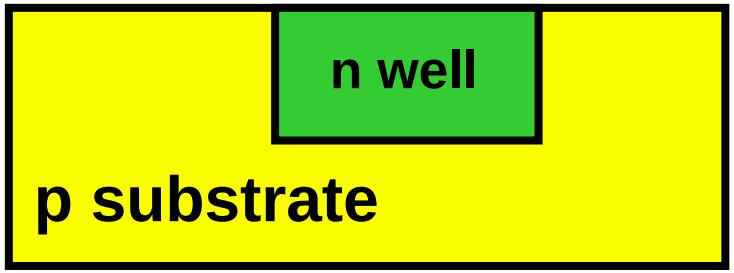
n-type



p-type

- "on" when V_g is high
- With n-type s/d
- Electrons (n) as carrier
- Built in p-type Si

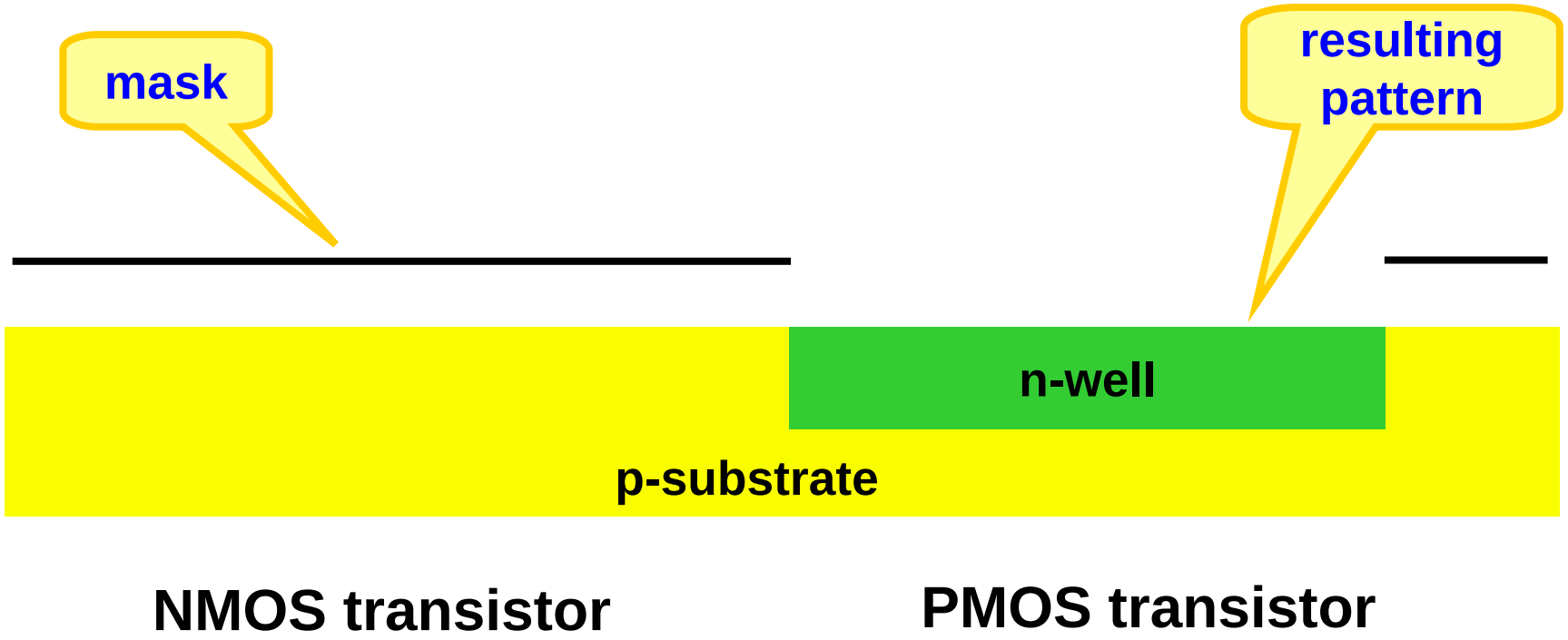
- "on" when V_g is low
- With p-type s/d
- Holes (p) as carrier
- Built in n-type Si



n-well (for PMOS) in p-type substrate (for NMOS)

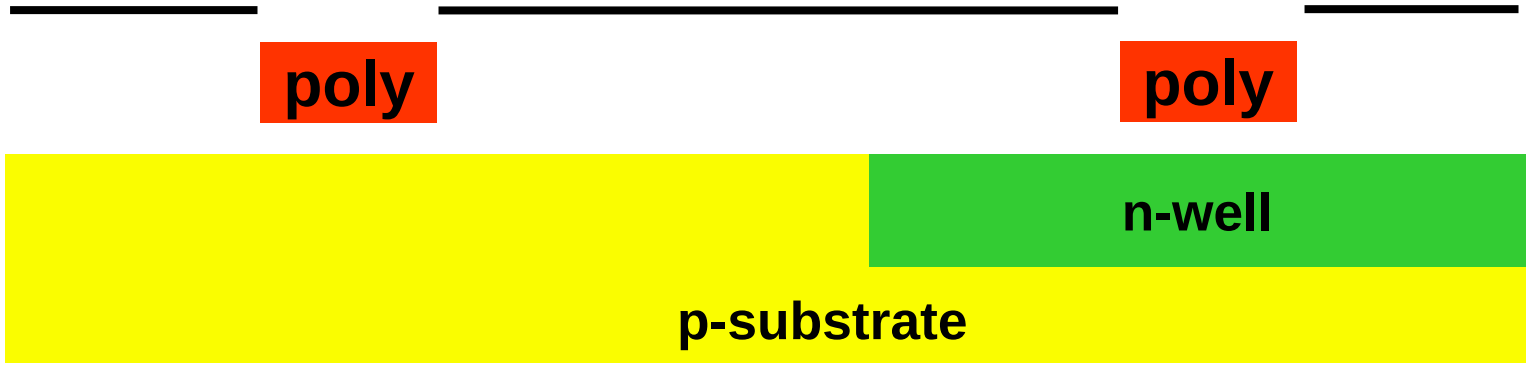
Outline of Process Flow

First place n-well to provide properly-doped substrate for n-type, p-type transistors :



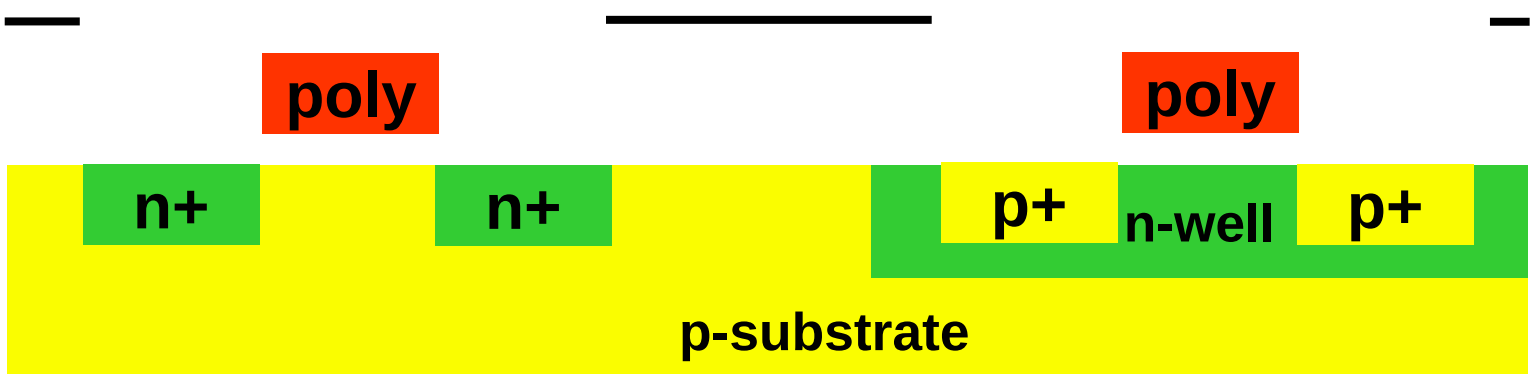
Outline of Process Flow, cont'd

Pattern gate next, to later act as a mask for source and drain diffusions:



Outline of Process Flow, cont'd

Add s/d diffusions,
with self-masking by poly gate:



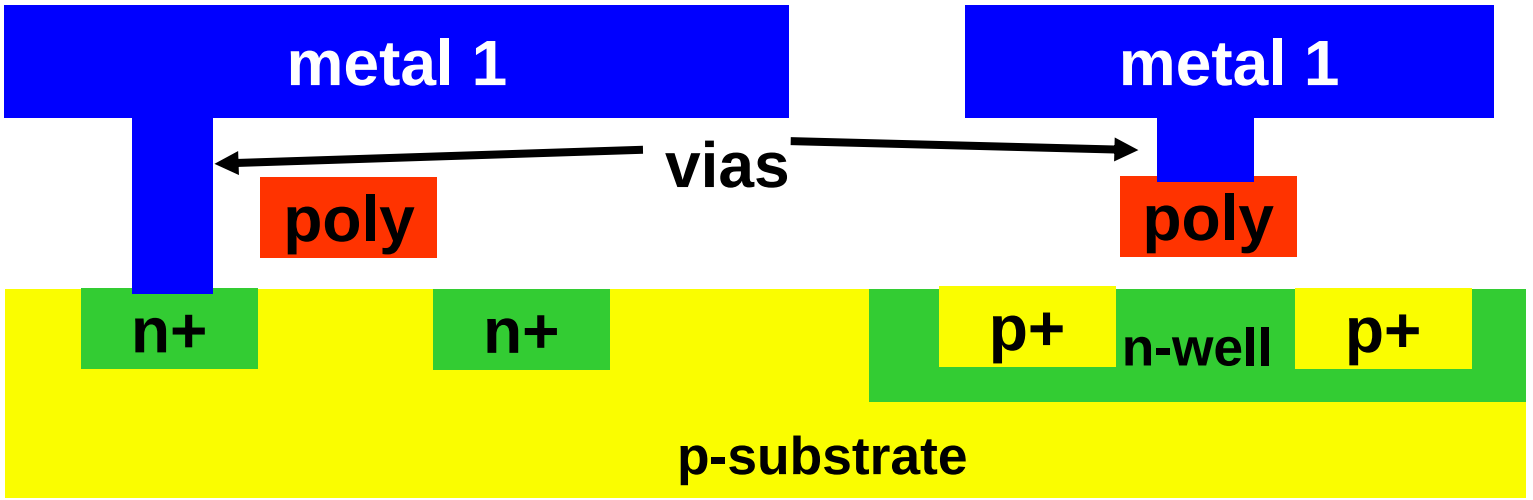
NMOS transistor **PMOS transistor**

Self-masking: Poly also works as a mask,
ensuring good alignment of s/d to gate

Outline of Process Flow, cont'd

Start adding metal layers:

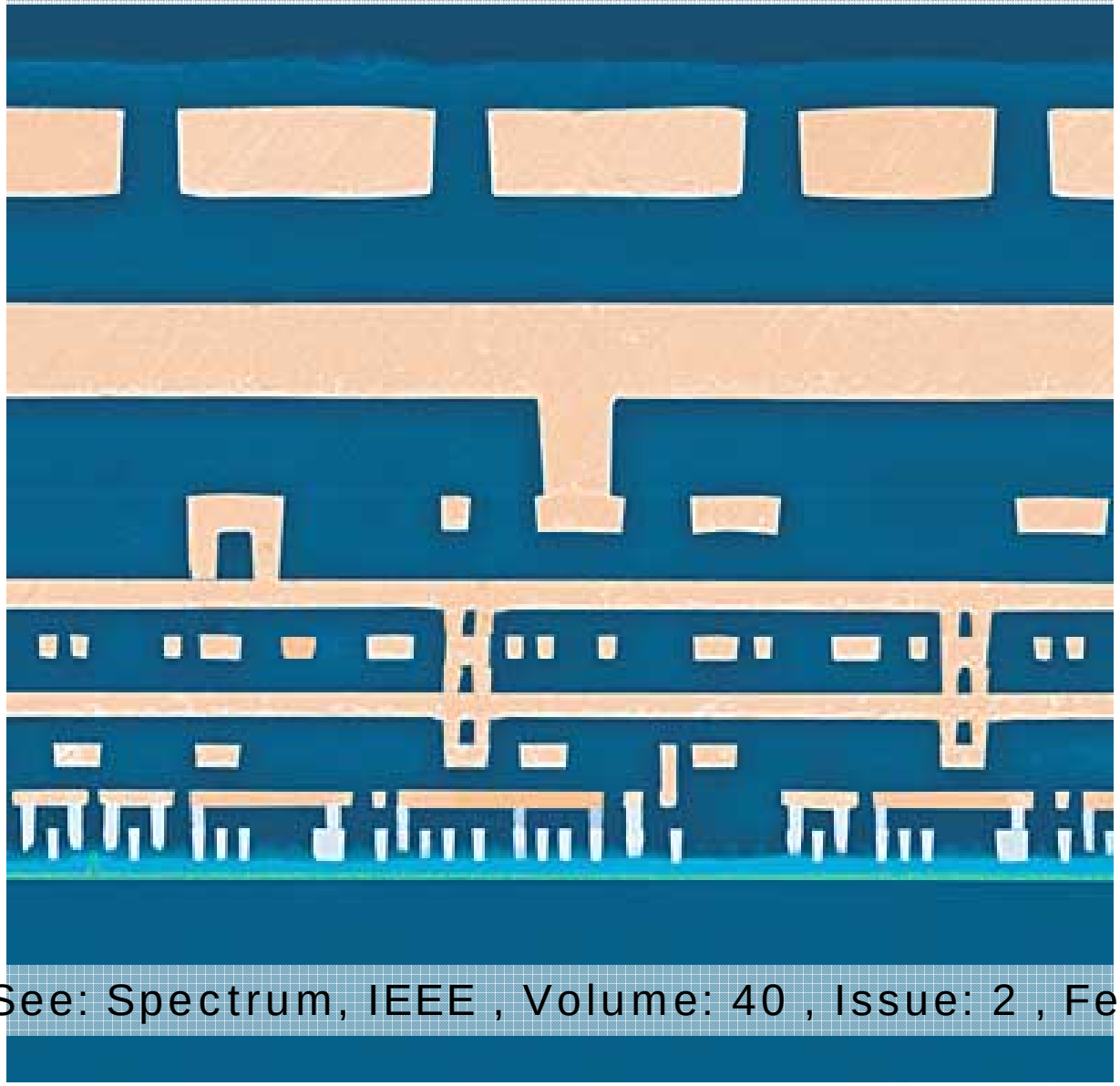
Via: contact hole between metal layers



NMOS transistor **PMOS transistor**

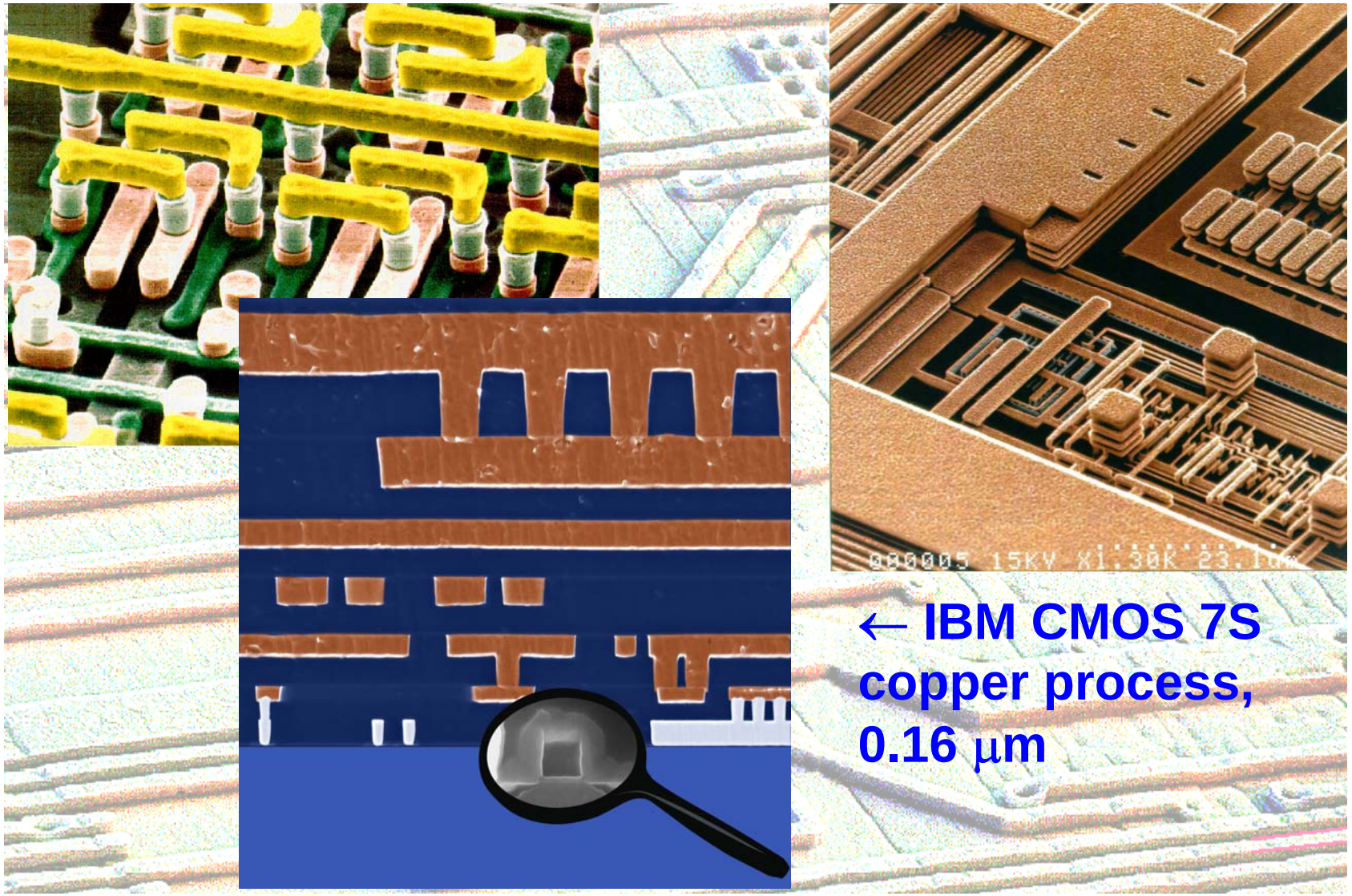
Similar for subsequent metal layers

Process Cross-section



See: Spectrum, IEEE , Volume: 40 , Issue: 2 , Feb. 2003

Interconnect Examples (motorola, ibm)



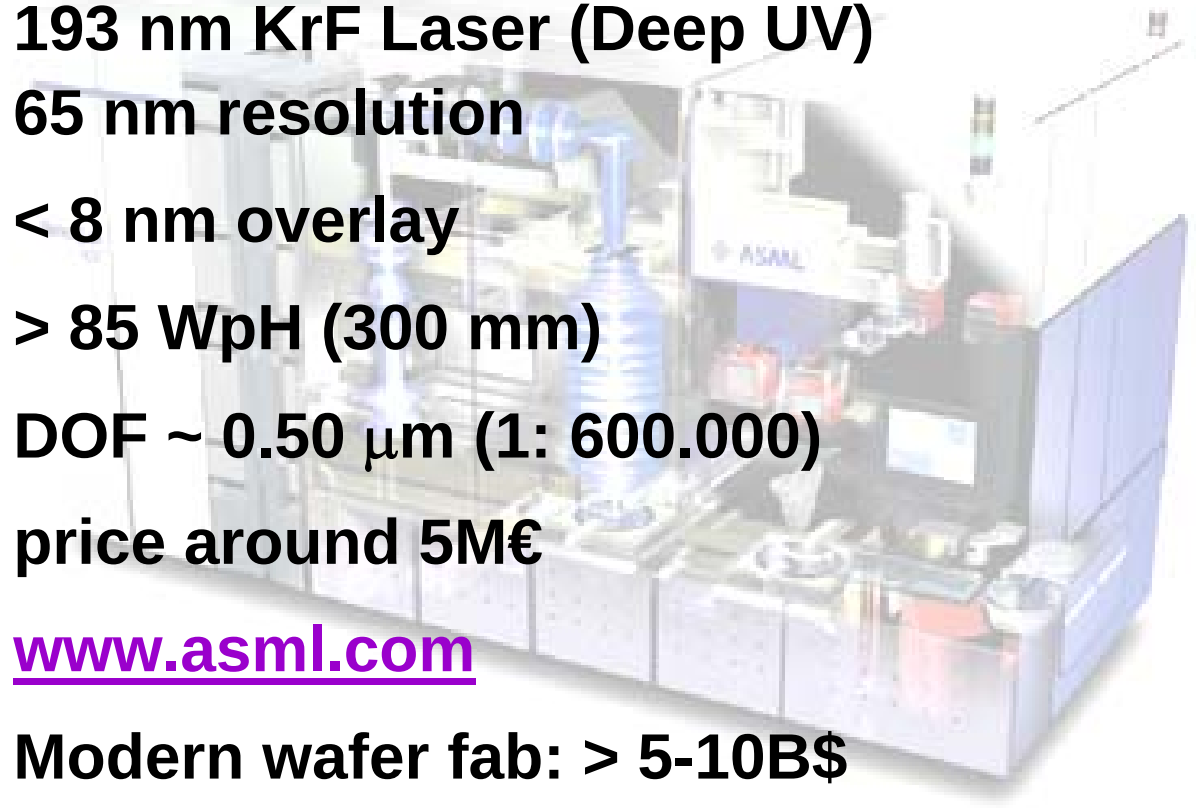
← IBM CMOS 7S copper process, 0.16 μm

IC Recipe Precisely Fixed

- **Process conditions (temperature, time, concentration, ...) very critical**
- **Many strong compatibility issues of materials and processes**
- **Very expensive and difficult to tune**
- **Very expensive equipment and facilities**
- **Need Billions of turnover for break-even**

Complex Lithographic Process

- **Example: ASML TWINSCAN™ XT:1250**
- **Sub wave length Lithography**
  193 nm KrF Laser (Deep UV)
- **65 nm resolution**
- **< 8 nm overlay**
- **> 85 WpH (300 mm)**
- **DOF ~ 0.50 μm (1: 600.000)**
- **price around 5M€**
- **www.asml.com**
- **Modern wafer fab: > 5-10B$**



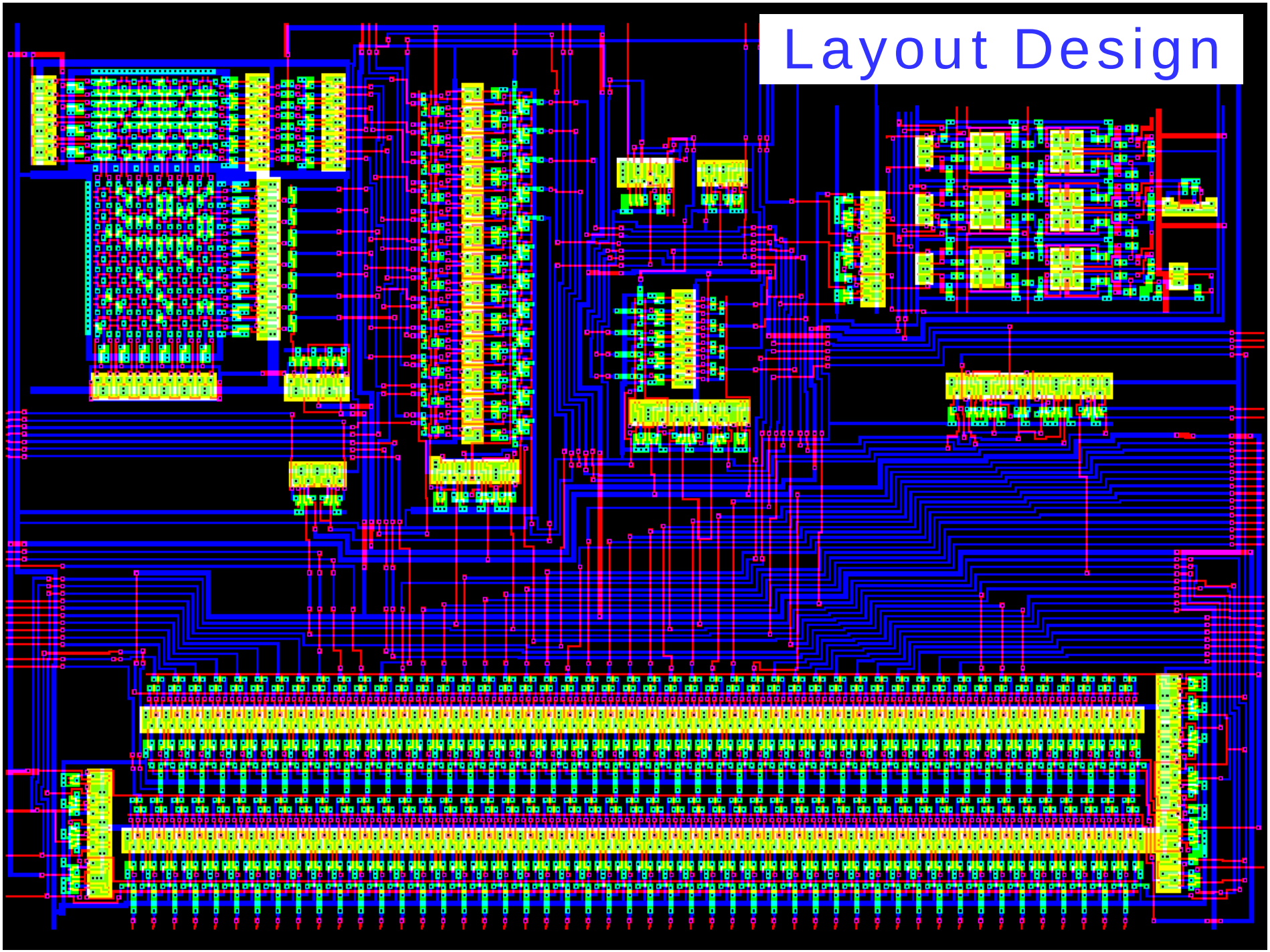
Compare Stepper Wafer Size and Resolution to NL scale

- **Wafer size: ∅ 300mm**
- **Resolution: 45nm**
- **Netherlands: 40.000 km² ~ 200km x 200km**

300mm	**1**	**45nm**
200km	**667x10³**	**3cm**

A ‘magnified’ waferstepper could ‘print’ the Netherlands with a resolution of 3 cm in 42 sec.

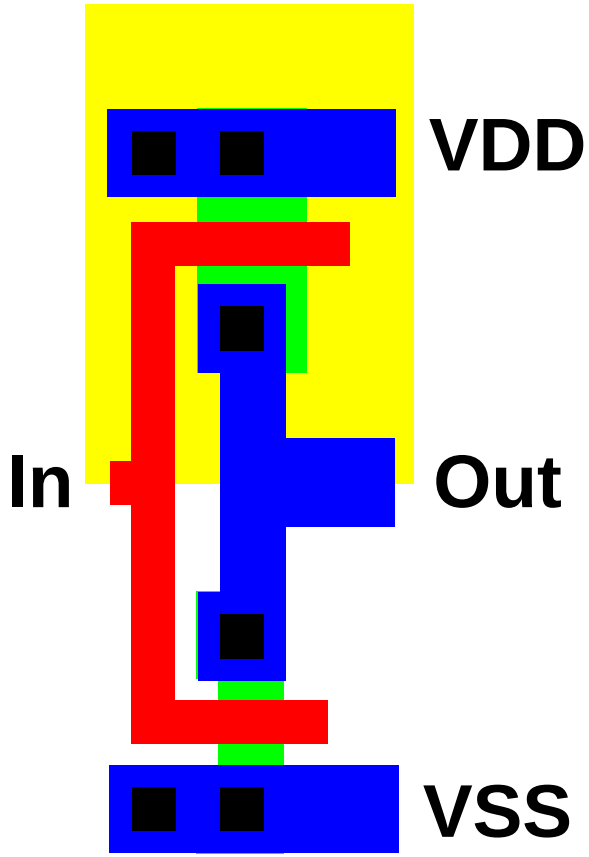
Equivalent to a 44 terabit camera (6.7x6.7 Mega pixel)


Layout Design

Layout Design

Layout Design Concepts

- **Layer map**
- **Layout examples**
- **Stick diagrams**



You should be able to understand such a drawing as well as simpler drawings called ‘stick diagram’

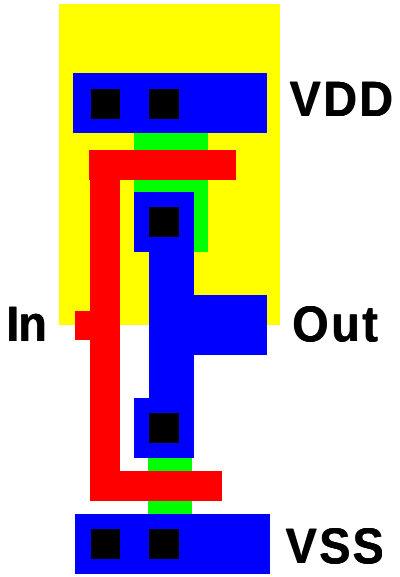
Layout Design

- Layout is design of fabrication masks
- Each mask is drawn in different color
- Layout is not a free-form drawing

  Most often: Manhattan Layout (rectangular)

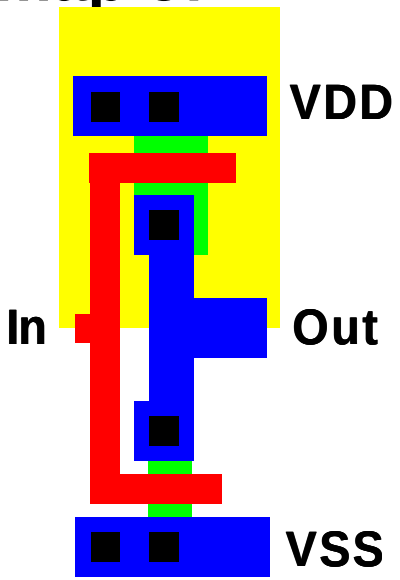
  Sometimes 45-degree angles

  Curved geometry only for special applications
- Layout should obey Design Rules



Layer Map

- **Layers are assigned colors and/or patterns, not always 1 to 1**
- **Is a matter of convention**
- **Site-dependent, process dependent, tool dependent**
- **Be prepared to reverse-engineer layer map of unknown layouts**



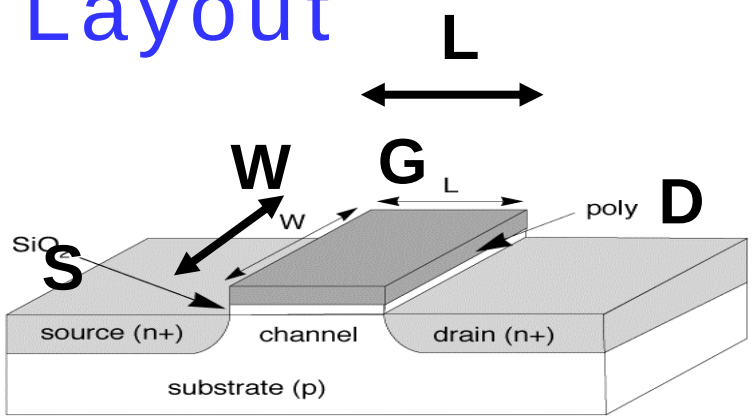
Our Reduced CMOS Layer Map

yellow		nwell – place for P-transistors
green		active – source and drain regions
red		polysilicon – gate material
blue		metal 1 – first interconnect metal
black		contact, via – hole in interlayer oxide

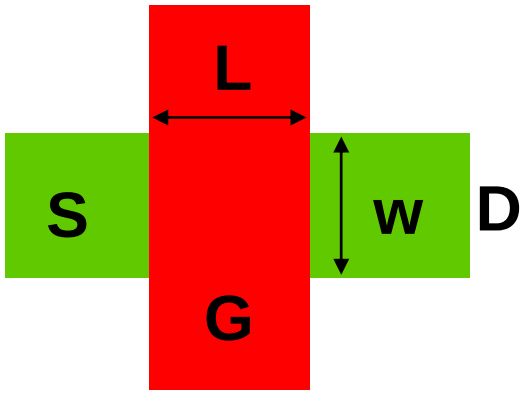
- Our layouts will be composed of these colors
- Or equivalent B/W patterns
- Compare to / instead of color plate 1
- Note: active = active area = diff = diffusion, well ≈ tub

Transistor Layout

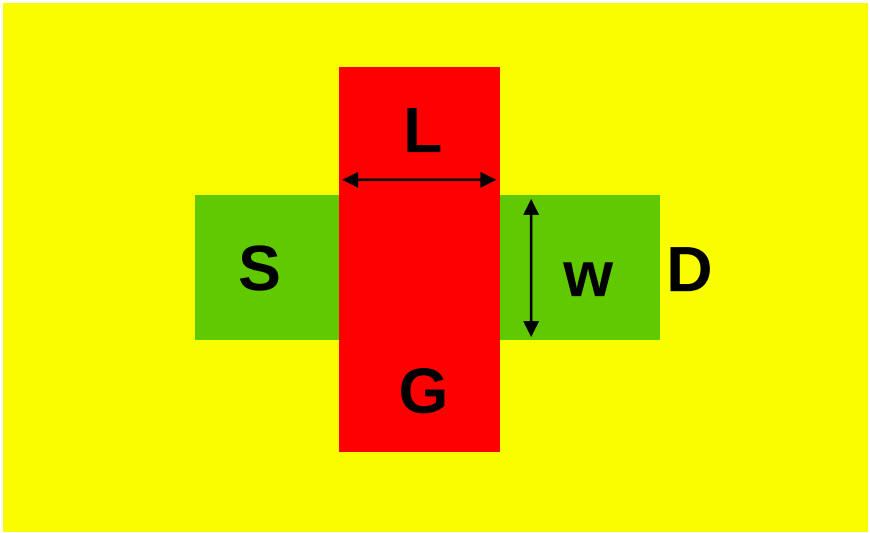
n-well (p-sub)



n-type

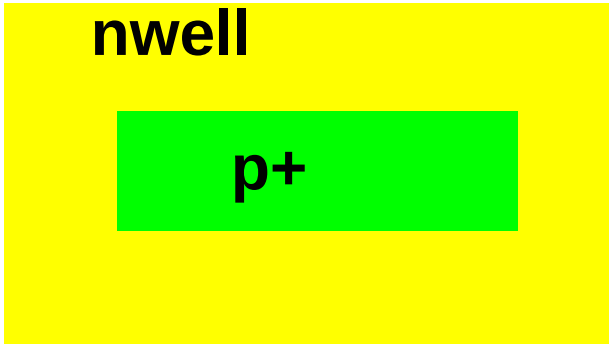


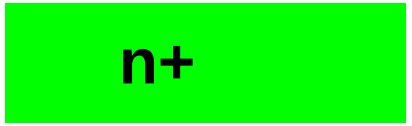
p-type



Polarity of Active Area

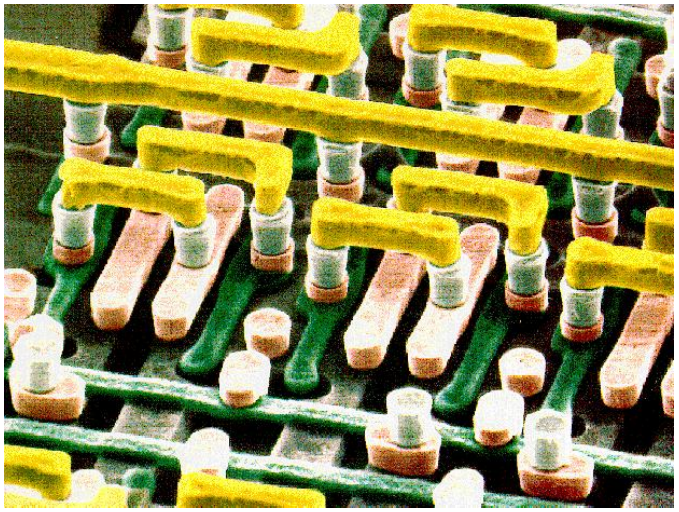
- **Active layer or active area is the source/drain implant layer (area). Usually abbreviated as 'active' only.**
- **Normally, a so-called select mask determines polarity of active**
- **See color plate 5**
- **We will implicitly define polarity of active by n-well**
- **Or we will even omit the nwell and use the context**

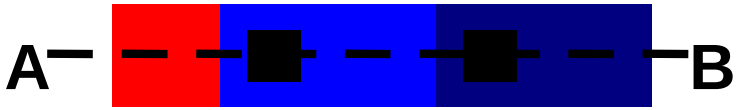




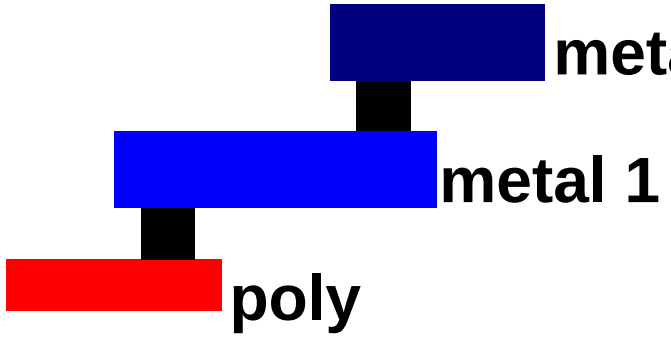
active

Contact Holes and Vias



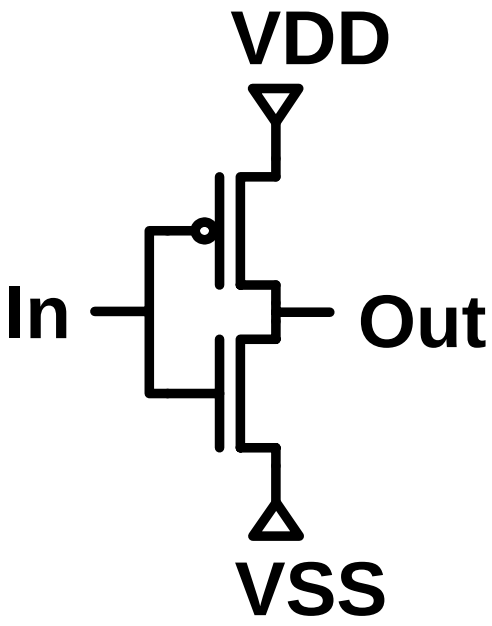


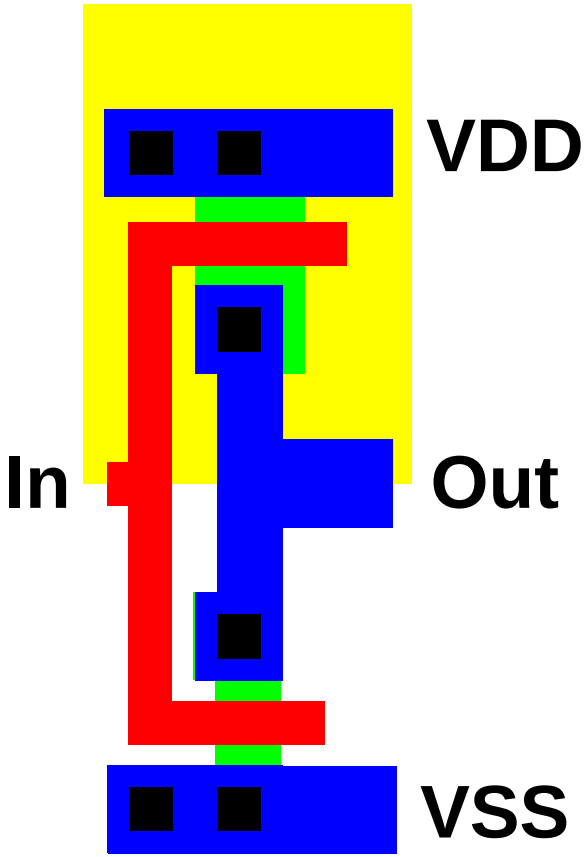
Layout (top view)



Cross-section along A-B

Invertor Layout

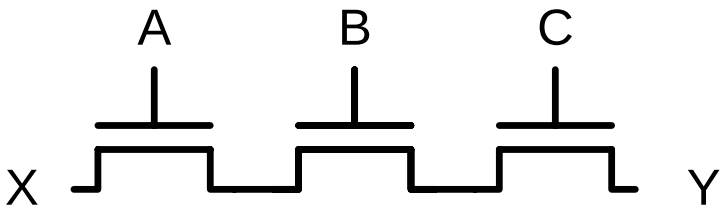




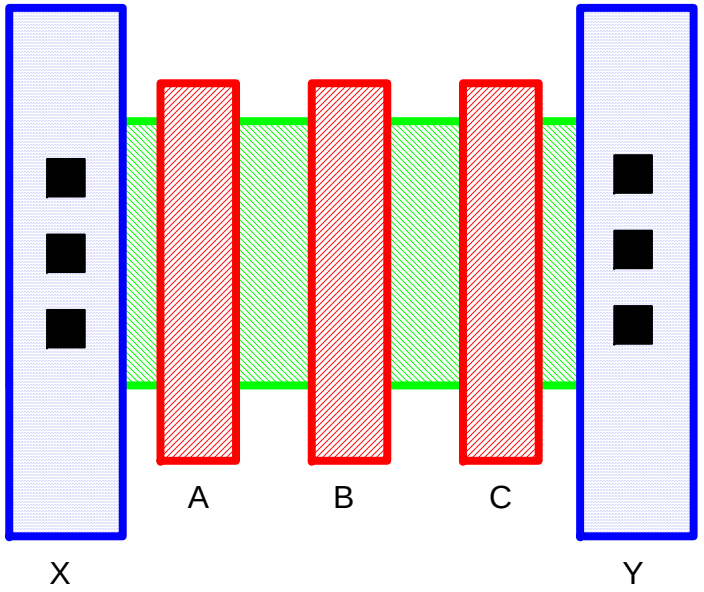
Main difficulty: you need to guess/extrapolate covered portions of the layout (e.g. green under blue)

Given such a layout, you should be able to draw the circuit on the left, as well as the different cross-sections

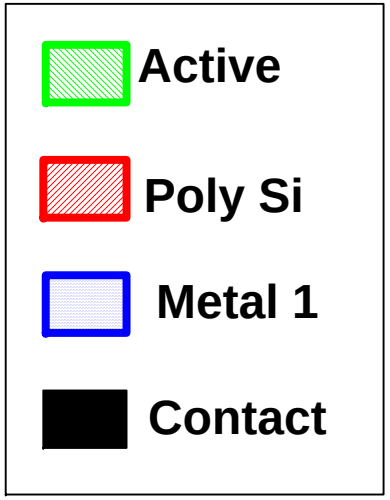
From Schematic to Layout



Transistor schematic



Layout



Exercise

Zie onderstaande lay-out van een transistor.

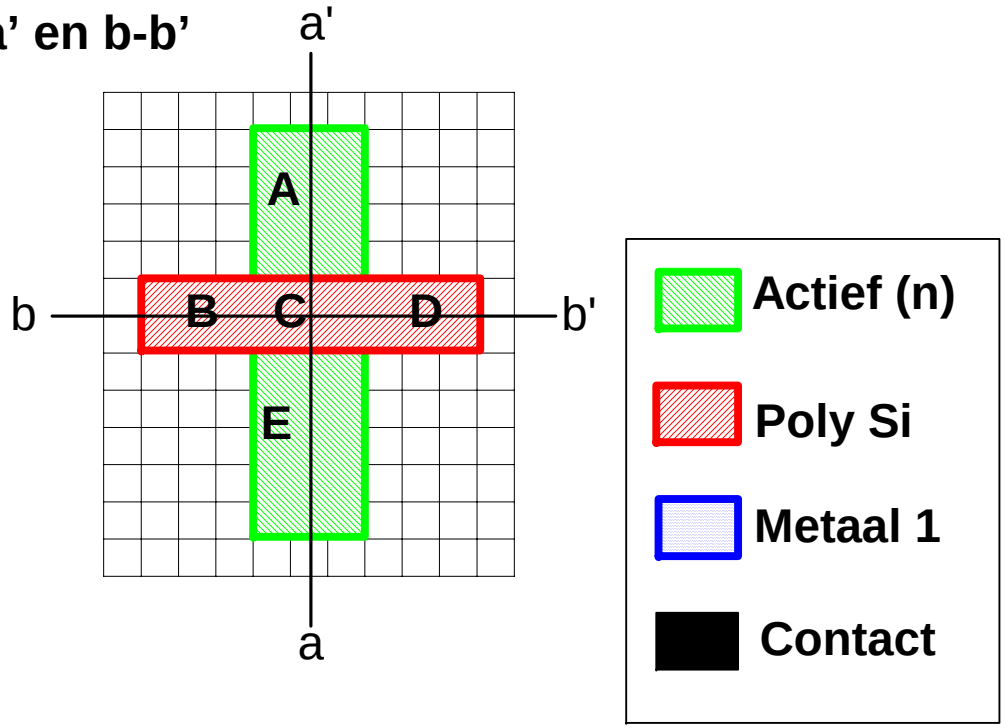
Geef voor ieder van de aansluitingen gate, source, drain aan uit welke letters A-E (zie de layout) het gebied bestaat.

G: .....

S: .....

D: .....

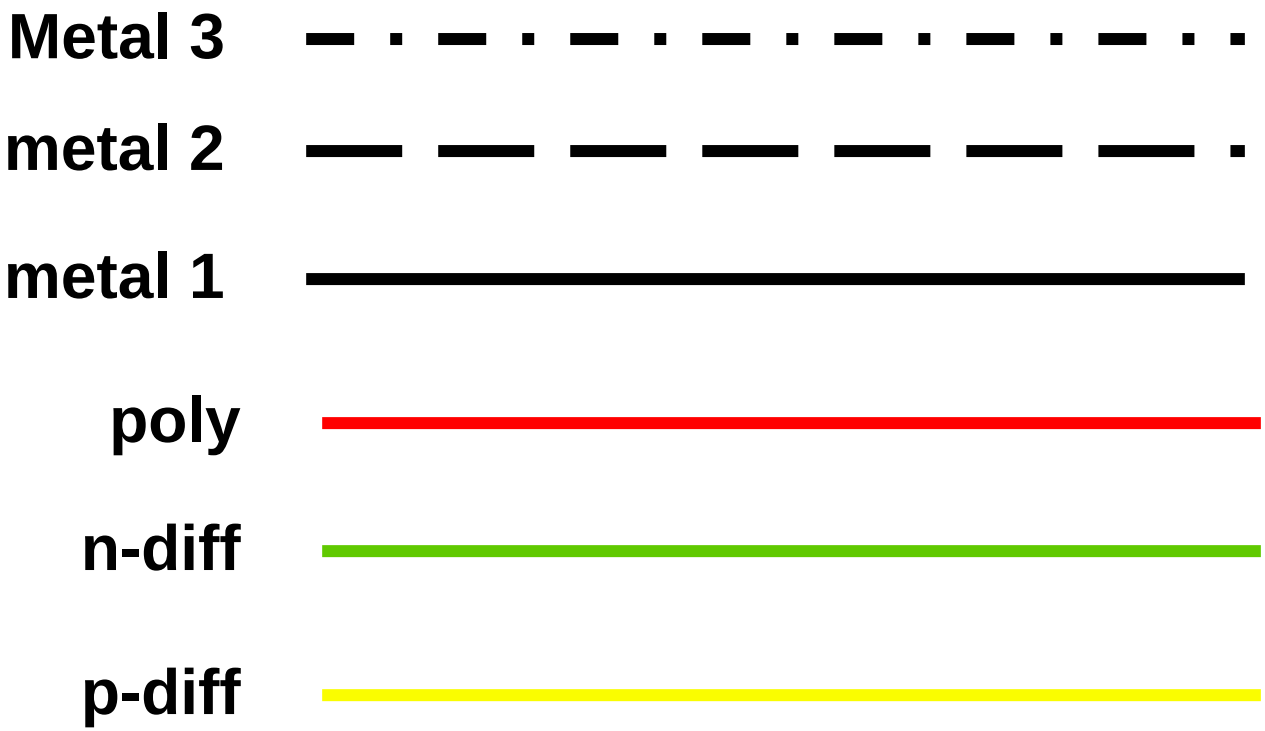
Teken een doorsnede langs a-a' en b-b'



Stick diagrams

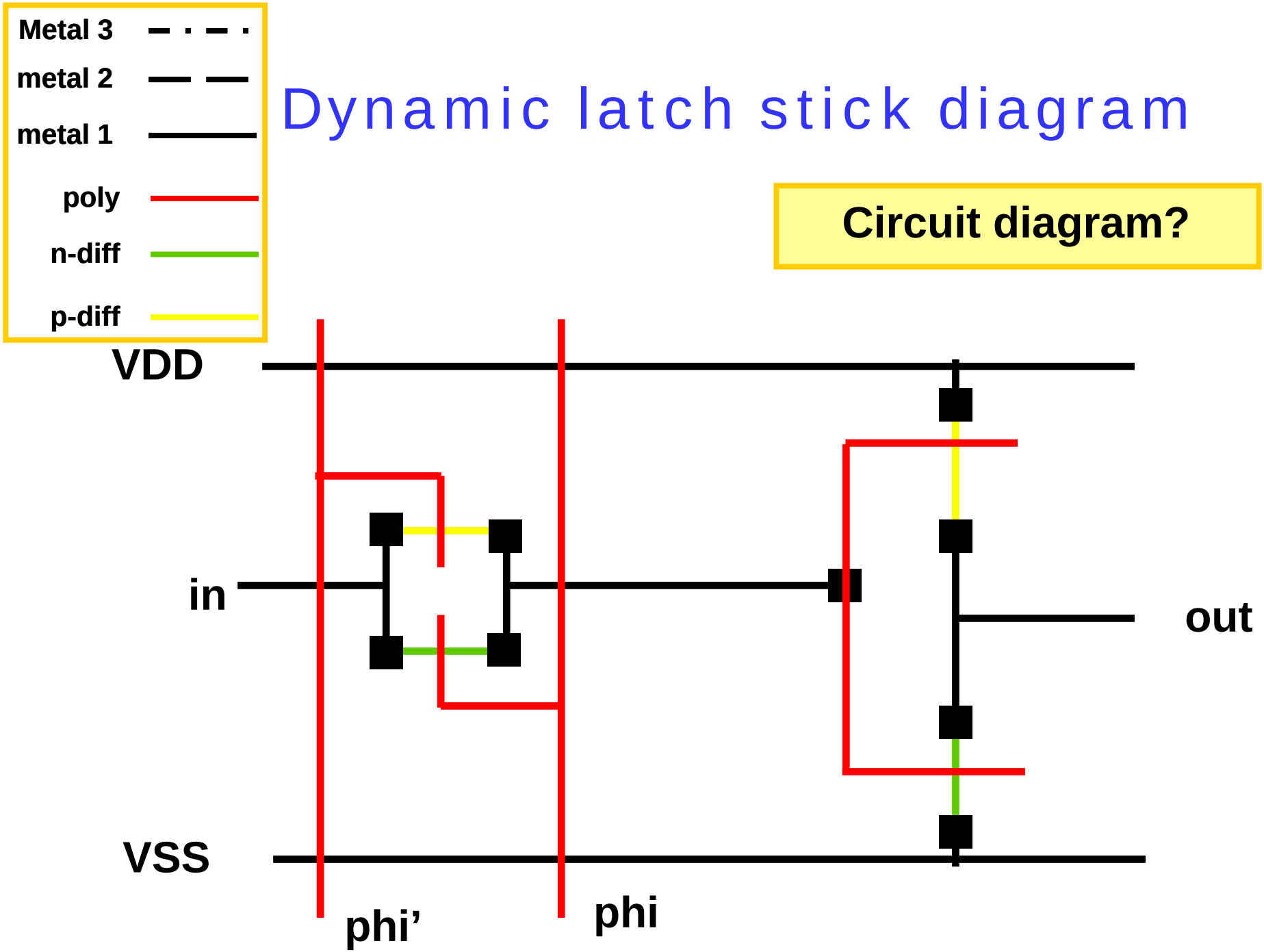
- **A stick diagram is a cartoon of a layout.**
- **Does show components/vias but only relative placement.**
- **Does not show exact placement, transistor sizes, wire lengths, wire widths, tub boundaries, some special components.**

Stick layers



- **Caution: stick diagrams don't display wells, use different colors for active area to distinguish between n-diff and p-diff**

Dynamic latch stick diagram

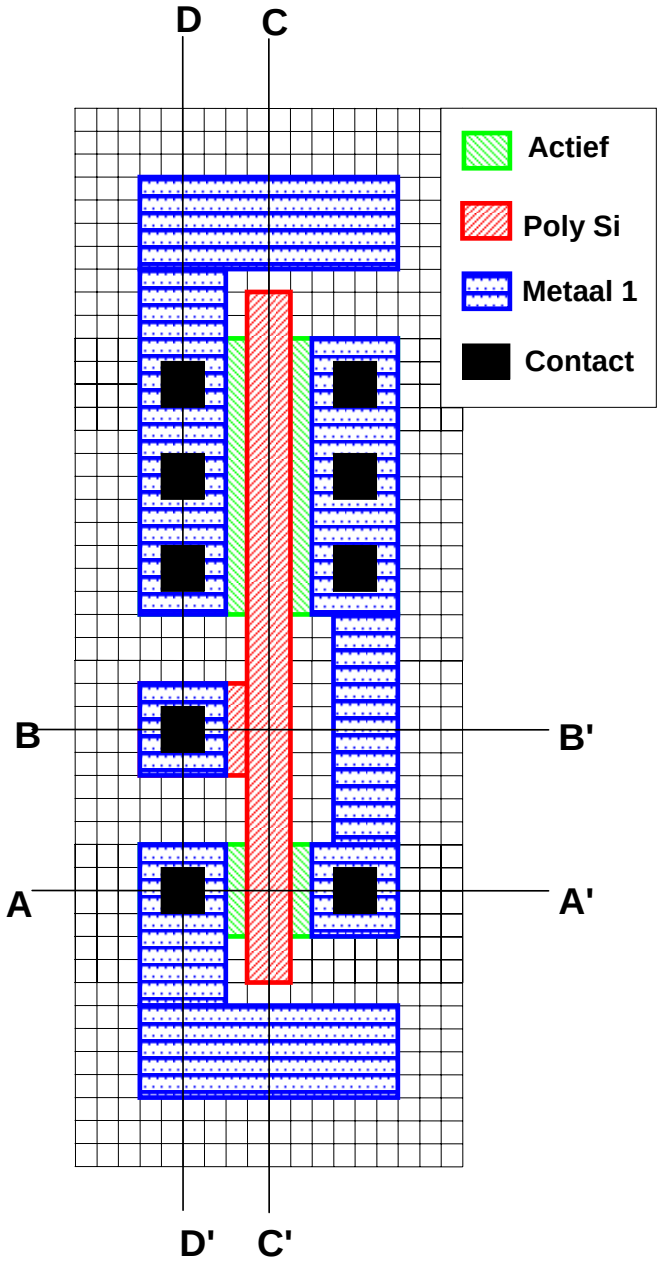


Design Rules

- The fabrication process will suffer from tolerances
- Chip features will have a practical minimum size to allow them to be fabricated reliably enough (with high enough yield)
- This is captured into a set of precise Design Rules
- Modern processes have terribly complex set of design rules as a compromise between flexibility and manufacturability
- We will ignore this subject
- But you will have to understand it during OP next year.

Zie bijgaande layout van een CMOS inverter

- **Teken doorsnedes langs A-A', B-B' en C-C'**
- **Welke van de twee transistoren is (vermoedelijk) de P-MOS transistor (waarom?)**
- **Teken voor deze keuze de layout van de N-well.**
- **Geef in de layout aan waar de Vss en Vdd aansluitingen zitten.**
- **Teken het transistor schema, met l/w ratio's**



Summary

- CMOS Processing
  - Photolithography
  - Material Deposition & Removal
  - Oxide Growth & Removal
- CMOS Process Outline
- Layout Design
  - Layer map
  - Layout examples
  - Stick diagrams
- Design Rules
  - Why we need design rules